

A4G50D1700NT2

1700V Silicon Carbide Schottky Diode



Features

- New Thin Wafer Technology
- Low Forward Voltage Drop (VF)
- Zero Reverse Recovery Current
- Zero Forward Recovery Voltage
- Positive Temperature Coefficient on VF
- Temperature-independent Switching

Benefits

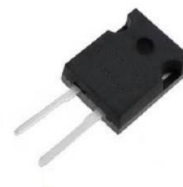
- Replace Bipolar with Unipolar Device
- Reduction of Heat Sink Size
- Parallel Devices Without Thermal Runaway
- Essentially No Switching Losses

Applications

- Switch Mode Power Supplies
- Uninterruptible Power Supplies
- Server/Telecom Power Supplies
- Industrial Power Supplies

Product Summary

V_{DS}	1700V
$I_D (T_C \leq 150^\circ\text{C})$	50A



Ordering Information

Part Number	Marking	Package	Packaging
A4G50D1700NT2	A4G50D1700NT2	TO-247-2	Tube

Absolute Maximum Ratings

Symbol	Parameter	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	1700	V
V_{RSM}	Surge Peak Reverse Voltage	1700	
V_R	DC Blocking Voltage	1700	
I_F	Forward Current	50 ($T_C \leq 150^\circ\text{C}$)	A
I_{FSM}	Non-Repetitive Forward Surge Current	500	A
P_{tot}	Power Dissipation	750 ($T_C = 25^\circ\text{C}$)	W
T_J, T_{stg}	Operating Junction and Storage Temperature	-55 to +175	$^\circ\text{C}$

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise specified)

Typical Performance-Static

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_F	Forward Voltage	$I_F = 50\text{A}, T_J = 25^\circ\text{C}$		1.45	1.65	V
		$I_F = 50\text{A}, T_J = 175^\circ\text{C}$		1.95	2.30	V
I_R	Reverse Current	$V_R = 1700\text{V}, T_J = 25^\circ\text{C}$		10	100	μA
		$V_R = 1700\text{V}, T_J = 175^\circ\text{C}$		50	500	μA

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C	Total Capacitance	$V_R = 0.1V, T_J = 25^{\circ}C, f = 1MHz$	5000	pF
		$V_R = 800V, T_J = 25^{\circ}C, f = 1MHz$	210	pF
		$V_R = 1700V, T_J = 25^{\circ}C, f = 1MHz$	180	pF
Q _C	Total Capacitive Charge	$V_R = 1700V, I_F = 50A$ $di/dt = 200A/\mu s, T_J = 25^{\circ}C$	420	nC

Thermal Characteristics

Symbol	Parameter	Value	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	0.2	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	80	°C/W
T _{sold}	Soldering Temperature	260	°C

Typical Performance

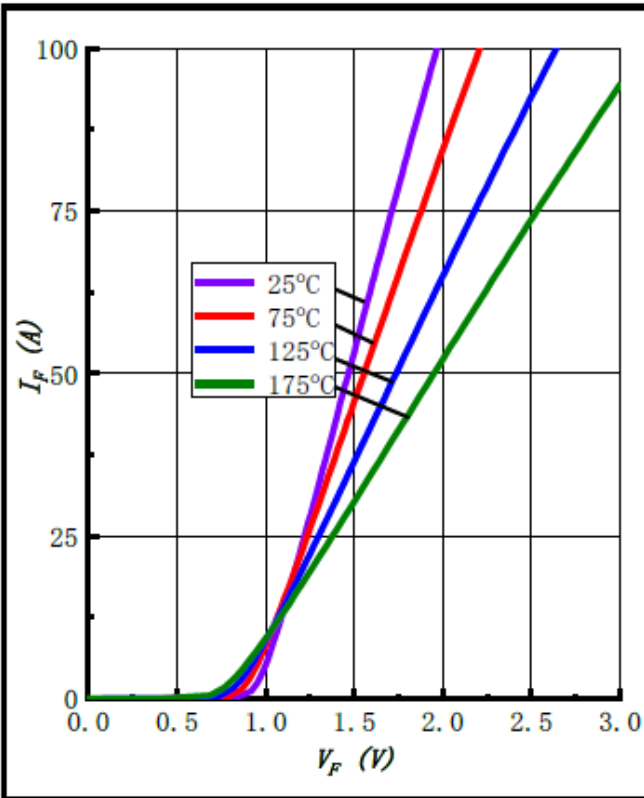


Figure 1. Forward Characteristics

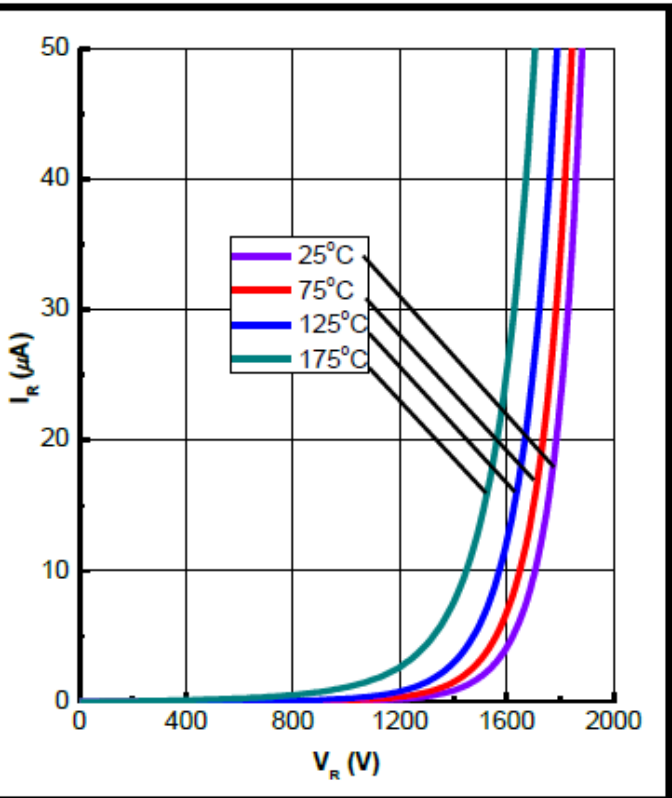


Figure 2. Reverse Characteristics

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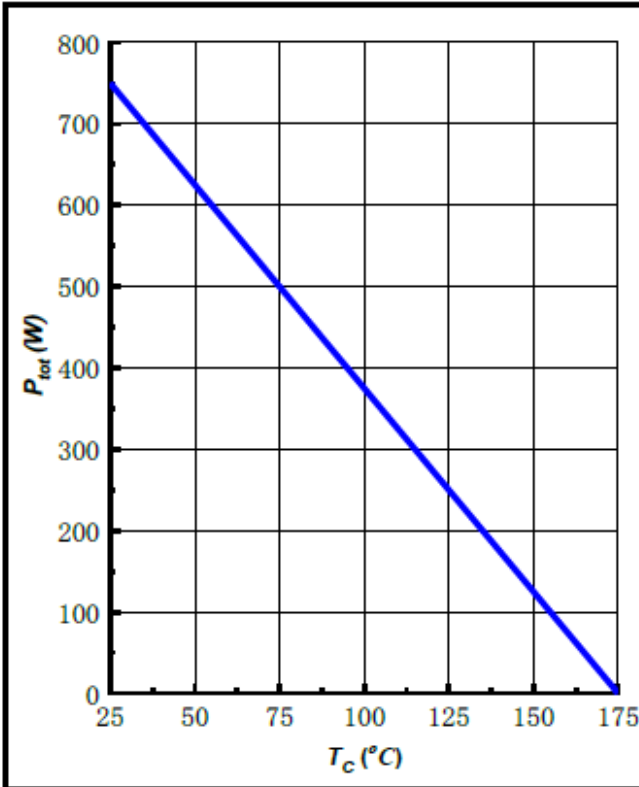


Figure 3. Power Derating

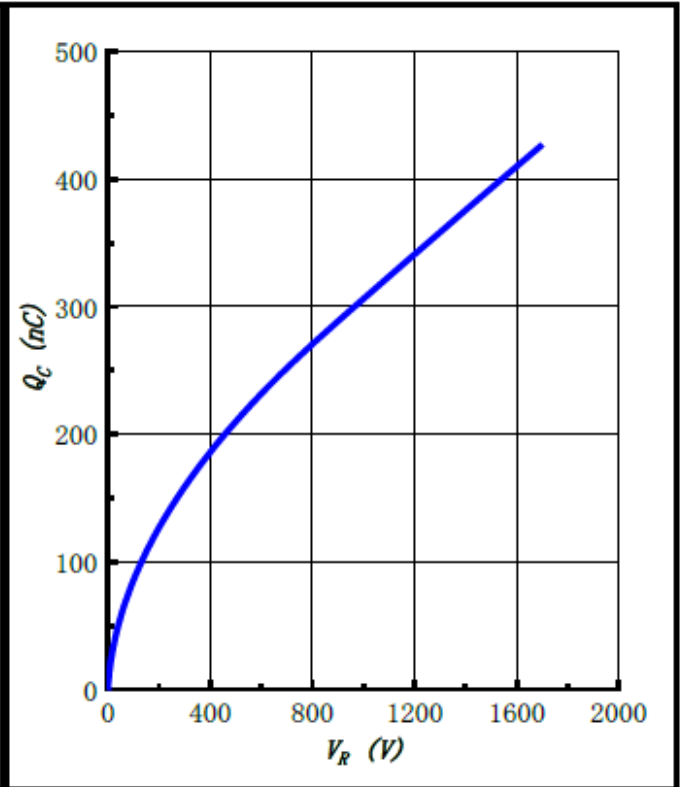


Figure 4. Total Capacitive Charge vs. Reverse Voltage

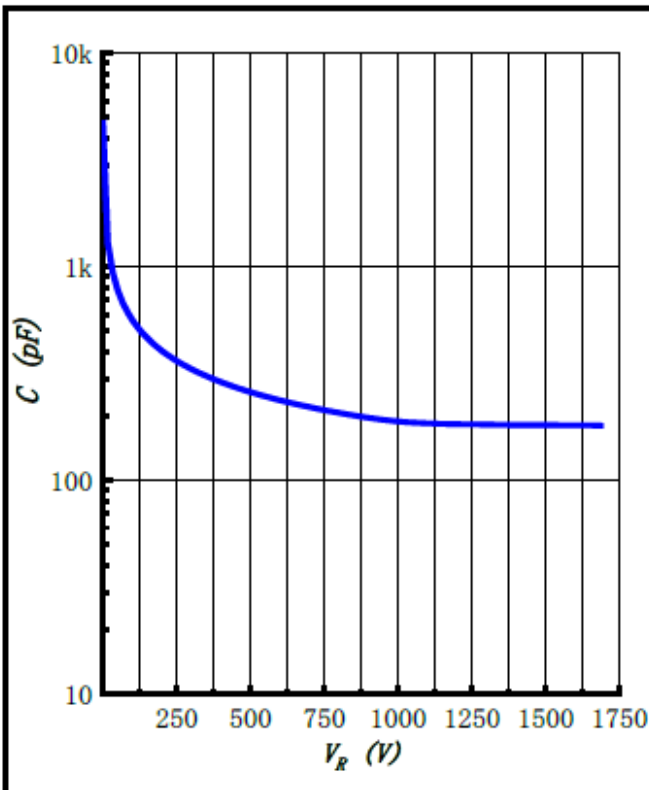


Figure 5. Total Capacitance vs. Reverse Voltage

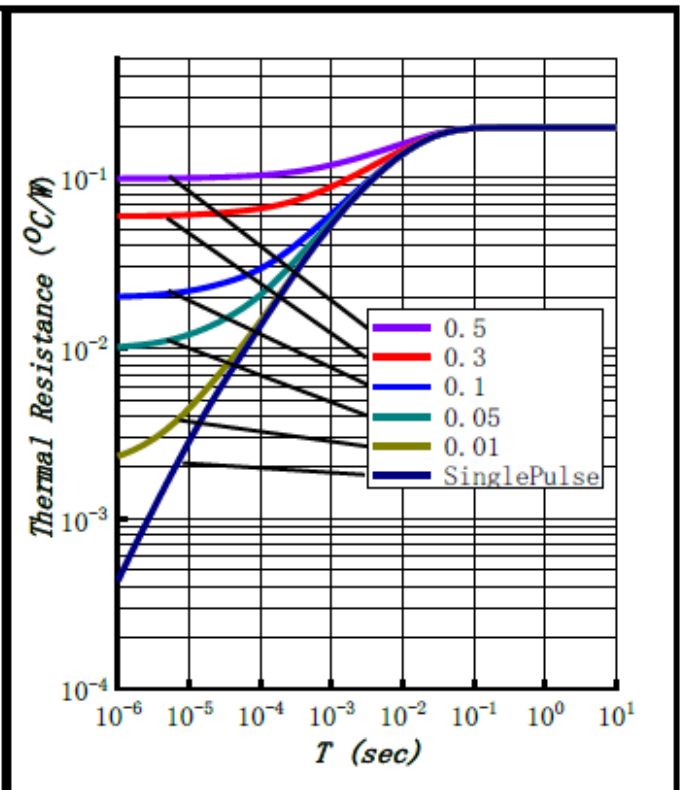
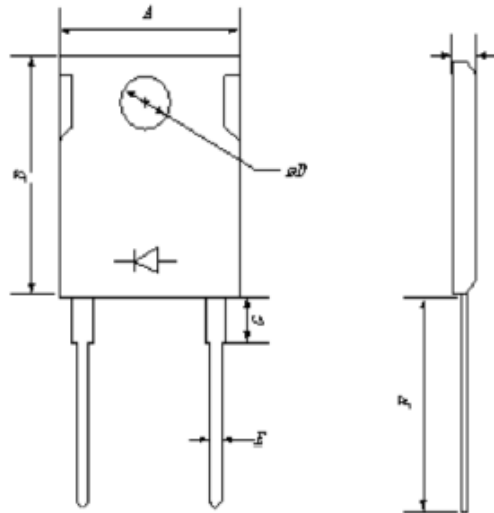


Figure 6. Transient Thermal Impedance

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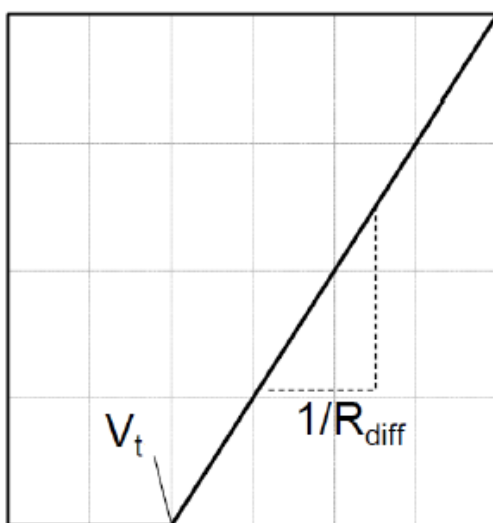
Package Drawing



Symbol	Min. (mm)	Typ. (mm)	Max. (mm)
A	14.18	15.75	17.33
B	18.45	20.5	22.55
C	4.50	5.00	5.50
D	3.15	3.50	3.85
E	1.08	1.20	1.32
F	18.27	20.32	22.33

Simplified Diode Model

Equivalent IV Curve for Model



Mathematical Equation

$$V_F = V_t + I_F \times R_{diff}$$

$$V_t = -0.0012 \times T_j + 1.0036 \text{ [V]}$$

$$R_{diff} = 2 \times 10^{-5} \times T_j^2 - 2.7 \times 10^{-3} \times T_j + 0.0755 \text{ [\Omega]}$$

Note:

T_j = Diode Junction Temperature In Degrees Celsius,
valid from 25°C to 175°C

I_F = Forward Current

Less than 100A

Revision version	Description	Date
1	Initial	08.2025